Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/786,817	DAVIS, LEO W.
Examiner	Art Unit
Christopher P. Schwartz	3683

Christopher P. Schwartz

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Class	Subclass	Date	Examiner
188	266.7	2/11/2008	CPS
	267.1		
	318		
	322.15	\	
	322.5	2/1/8	CPS

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
188	allabove	2/11/2008	CPS
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